

# 1200V N-Channel Silicon Carbide Power MOSFET

## FEATURES

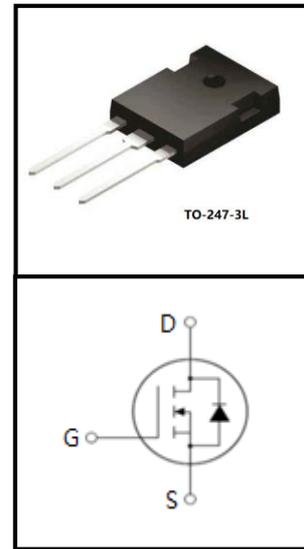
- Low On-Resistance
- Low Capacitance
- Avalanche Ruggedness
- Halogen Free, RoHS Compliant

## BENEFITS

- Higher System Efficiency
- Parallel Device Convenience
- High Temperature Application
- High Frequency Operation

## APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- Uninterruptible Power Supply (UPS)
- EV Charging station & Motor Drives
- Solar/ Wind Renewable Energy
- Power Inverters & DC/DC Converters



Device Marking and Package Information		
Device	Package	Marking
C2M120W280	TO-247-3L	C2M120W280

Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ , unless otherwise noted				
Parameter	Symbol	Test Conditions	Value	Unit
Drain-Source Voltage	$V_{DSS}$	$V_{GS}=0V, I_{DS}=100\mu A$	1200	V
Continuous Drain Current	$I_D$	$V_{GS}=20V, T_C=25^\circ\text{C}$	10	A
		$V_{GS}=20V, T_C=110^\circ\text{C}$	8	
Pulsed Drain Current	$I_{DM}$	$t_{pw}$ limitation per Fig.17	23	
Single Pulse Avalanche Energy	$E_{AS}$	$V_{DD}=100V, I_D=5A$	310	mJ
Power Dissipation	$P_D$	$T_C=25^\circ\text{C}$	80	W
Recommend Gate Source Voltage	$V_{GS, op}$	Static	-5/+20	V
Maximum Gate Source Voltage	$V_{GS, max}$	AC ( $f > 1\text{Hz}$ )	-10/+25	
Soldering Temperature	$T_L$		260	$^\circ\text{C}$
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$		-55/+150	

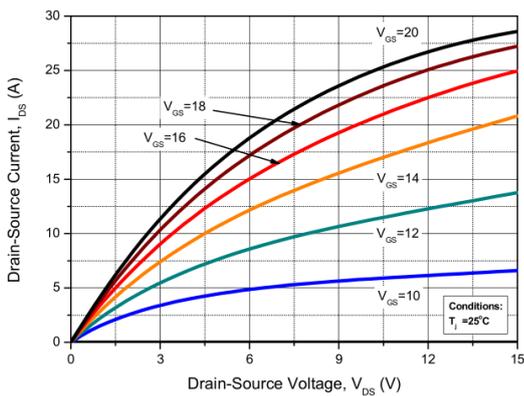
Thermal Resistance				
Parameter	Symbol	Value	Unit	
Thermal Resistance, Junction-to-Case	$R_{thJC}$	1.55	K/W	

<b>Specifications</b> $T_J = 25^{\circ}\text{C}$ , unless otherwise noted						
Parameter	Symbol	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
<b>Static</b>						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{V}, I_D = 100\mu\text{A}$	1200	--	--	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 1200\text{V}, V_{GS} = 0\text{V}, T_J = 25^{\circ}\text{C}$	--	<1	50	$\mu\text{A}$
		$V_{DS} = 1200\text{V}, V_{GS} = 0\text{V}, T_J = 150^{\circ}\text{C}$	--	1	200	
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = 20\text{V}, V_{DS} = 0\text{V}$	--	--	250	nA
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = 10\text{V}, I_D = 2.5\text{mA}$	--	2.6	--	V
Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = 20\text{V}, I_D = 5\text{A}$	--	280	360	m $\Omega$
		$V_{GS} = 20\text{V}, I_D = 5\text{A}, T_J = 150^{\circ}\text{C}$	--	420	--	
<b>Dynamic</b>						
Input Capacitance	$C_{iss}$	$V_{GS} = 0\text{V}$ $V_{DS} = 800\text{V}$ $f = 1.0\text{MHz}$ $V_{AC} = 25\text{mV}$	--	494	--	pF
Output Capacitance	$C_{oss}$		--	34	--	
Reverse Transfer Capacitance	$C_{rss}$		--	8	--	
Effective Output Capacitance, Energy Related	$C_{o(er)}$		$V_{GS} = 0\text{V}$ $V_{DS} = 0 \text{ to } 800\text{V}$	--	43	
Effective Output Capacitance, Time Related	$C_{o(tr)}$	$I_D = \text{const.}, V_{GS} = 0\text{V}$ $V_{DS} = 0 \text{ to } 800\text{V}$	--	56	--	
Total Gate Charge	$Q_g$	$V_{DS} = 800\text{V},$ $V_{GS} = -5/+20\text{V},$ $I_D = 5\text{A}$	--	47	--	nC
Gate-Source Charge	$Q_{gs}$		--	10	--	
Gate-Drain Charge	$Q_{gd}$		--	25	--	
Gate plateau voltage	$V_{pl}$		--	8.5	--	V
Turn-on Delay Time	$t_{d(on)}$	$V_{DS} = 800\text{V}$ $V_{GS} = -4/20\text{V}$ $I_D = 4.8\text{A}$ $R_L = 167\Omega$ $R_{G(ext)} = 2.7\Omega$	--	24	--	ns
Turn-on Rise Time	$t_r$		--	22	--	
Turn-off Delay Time	$t_{d(off)}$		--	30	--	
Turn-off Fall Time	$t_f$		--	29	--	
Coss Stored Energy	$E_{oss}$	$V_{GS} = 0\text{V}, V_{DS} = 800\text{V}$ $f = 1\text{MHz}, V_{AC} = 25\text{mV}$	--	18*	--	$\mu\text{J}$
Turn-on Switching Energy	$E_{on}$	$V_{DS} = 800\text{V}, V_{GS} = 0/20\text{V}$ $I_D = 5\text{A}, R_{G(ext)} = 2.7\Omega$	--	17*	--	
Turn-off Switching Energy	$E_{off}$		--	23*	--	
Internal Gate Resistance	$R_{G(int.)}$	$f = 1\text{MHz}, V_{AC} = 25\text{mV}$	--	3.7	--	$\Omega$

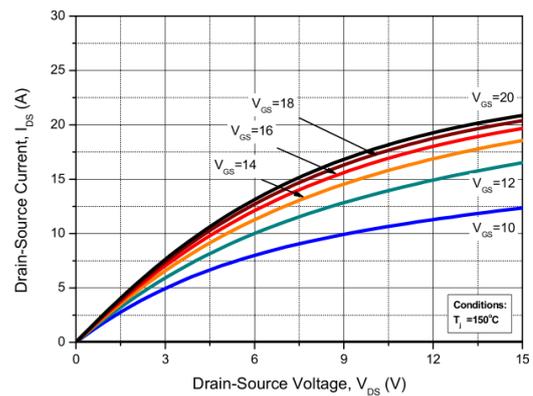
\*Base on the results of calculation, note that the energy loss caused by the reverse recovery of FWD is not included in  $E_{on}$ .

Built-in SiC Diode Characteristics						
Continuous Diode Forward Current	$I_S$	$V_{GS} = -5V$	--	11	--	A
Inverse Diode Forward Voltage	$V_{SD}$	$I_S = 1.25A, V_{GS} = -5V$	--	4.4	--	V
Reverse Recovery Time	$t_{rr}$	$V_{GS} = 0V,$ $I_F = 5A, V_{DS} = 400V,$ $di_F/dt = 300A/\mu s$	--	47	--	ns
Reverse Recovery Charge	$Q_{rr}$		--	36	--	nC
Peak Reverse Recovery Current	$I_{rrm}$		--	1.5	--	A

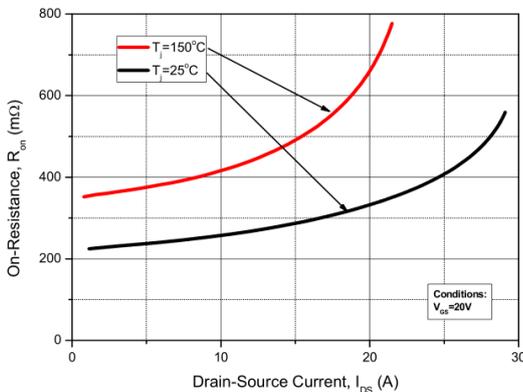
### Typical Device Performance



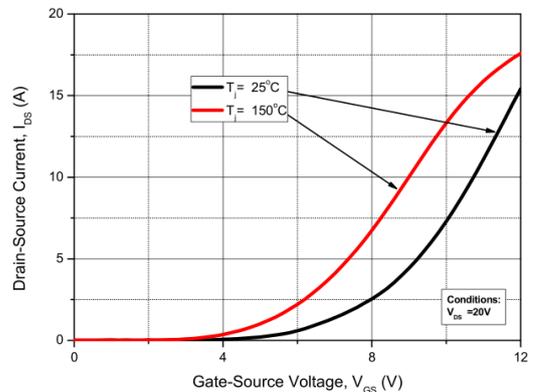
**Fig. 1 Forward Output Characteristics at  $T_j = 25^\circ C$**



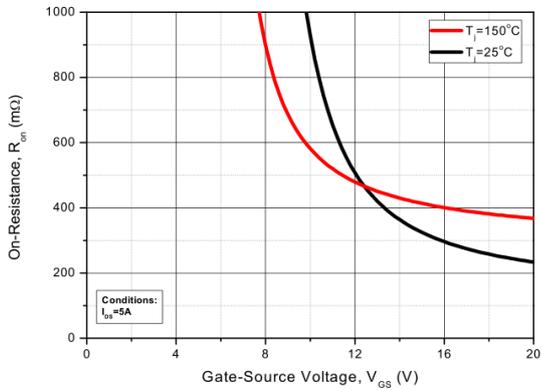
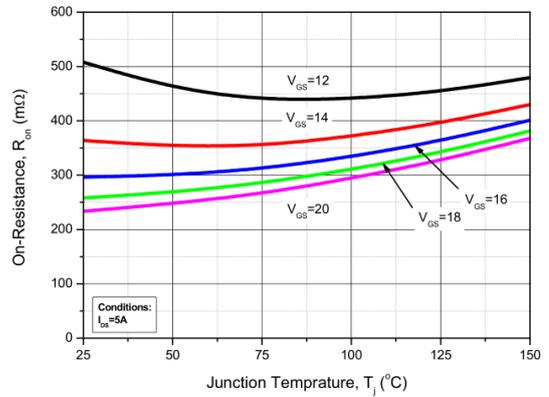
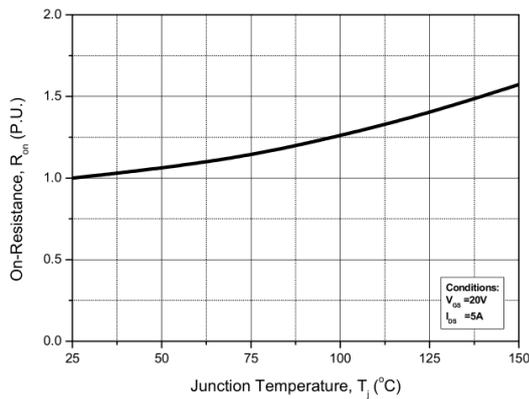
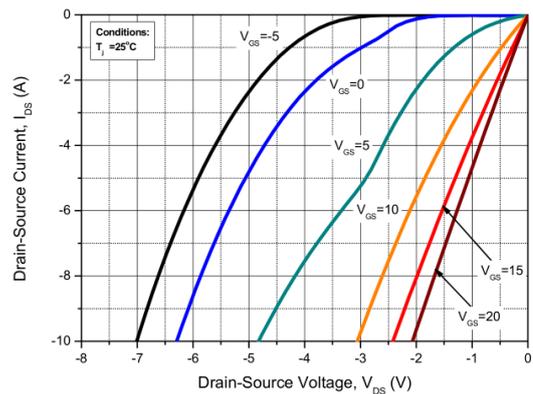
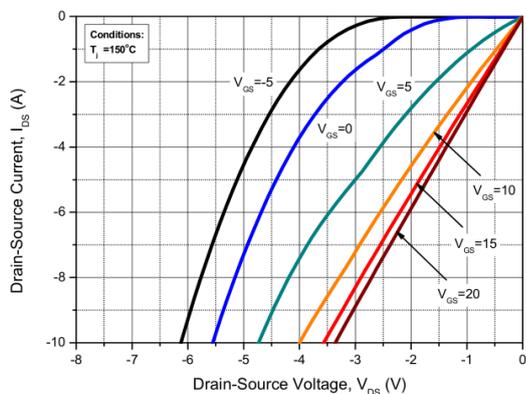
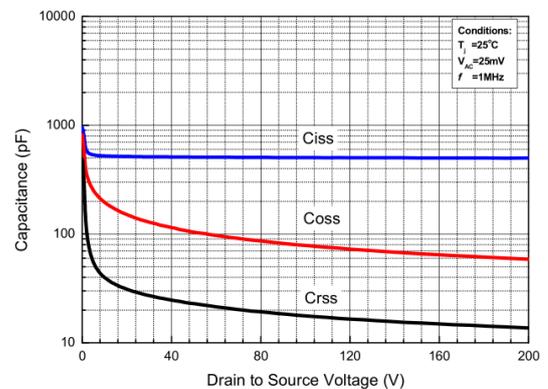
**Fig. 2 Forward Output Characteristics at  $T_j = 150^\circ C$**



**Fig. 3 On-Resistance vs. Drain Current for Various  $T_j$**



**Fig. 4 Transfer Characteristics for Various  $T_j$**

**Typical Device Performance**

**Fig. 5 On-Resistance vs. Gate Voltage for Various  $T_j$** 

**Fig. 6 On-Resistance vs. Temperature for Various Gate Voltage**

**Fig. 7 Normalized On-Resistance vs. Temperature**

**Fig. 8 Reverse Output Characteristics at  $T_j = 25^\circ\text{C}$** 

**Fig. 9 Reverse Output Characteristics at  $T_j = 150^\circ\text{C}$** 

**Fig. 10 Capacitances vs. Drain to Source Voltage (0 - 200V)**

Typical Device Performance

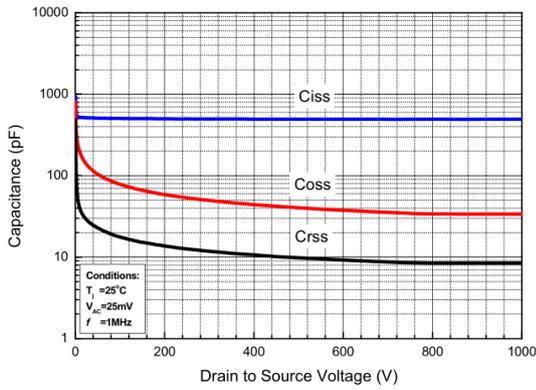


Fig. 11 Capacitances vs. Drain to Source Voltage (0 - 1000V)

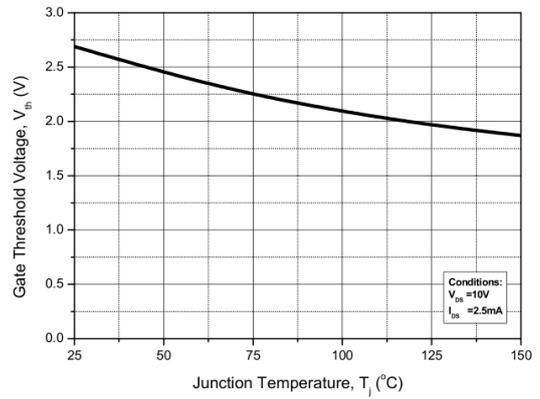


Fig. 12 Threshold Voltage vs. Temperature

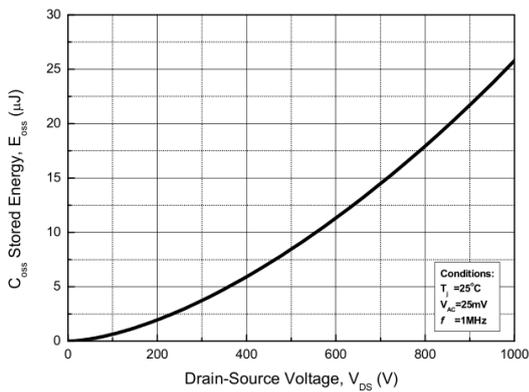


Fig. 13 Output Capacitor Stored Energy\*

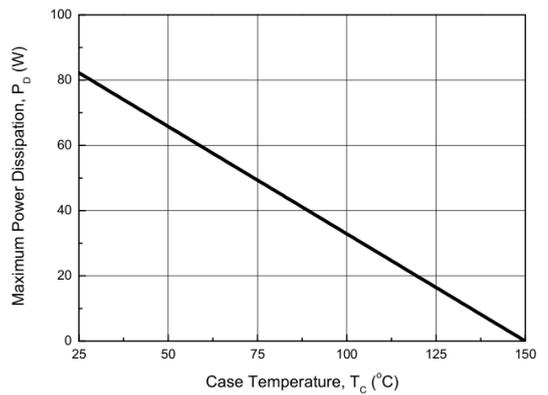


Fig. 14 Maximum Power Dissipation Derating vs. Case Temperature

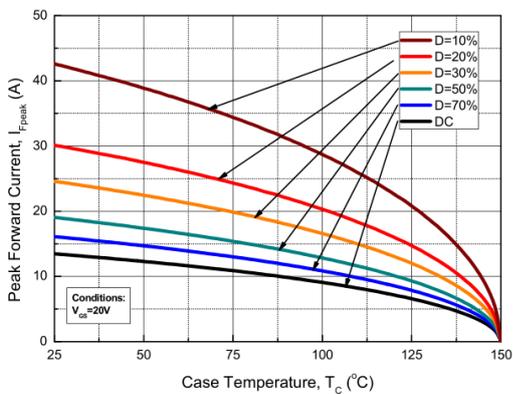


Fig. 15 Drain Current Derating vs. Case Temperature

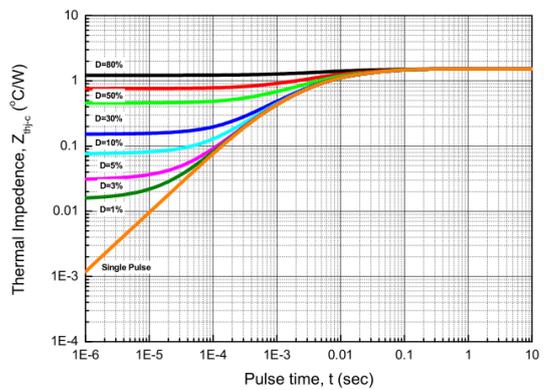


Fig. 16 Transient Junction to Case Thermal Impedance

Typical Device Performance

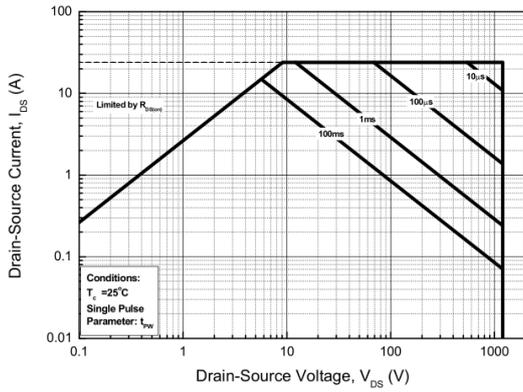


Fig. 17 Safe Operating Area

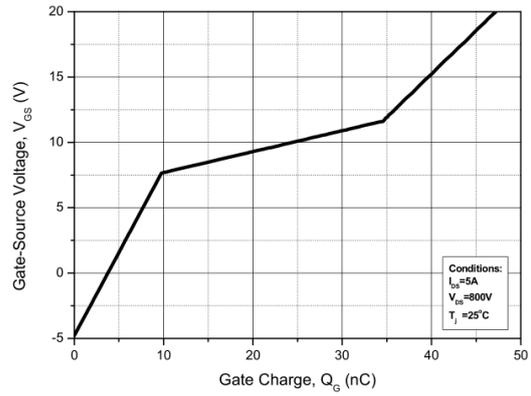


Fig. 18 Gate Charge Characteristics

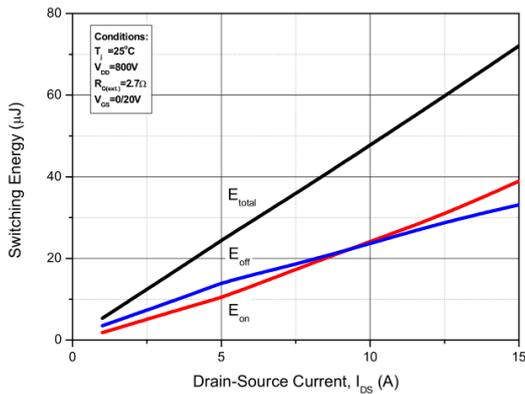


Fig. 19 Clamped Inductive Switching Energy vs. Drain Current ( $V_{DD}=800\text{V}$ )\*

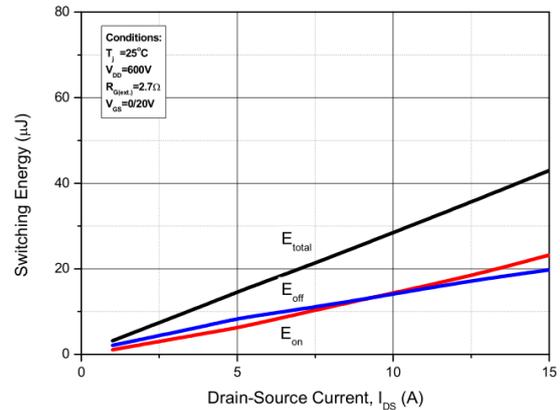


Fig. 20 Clamped Inductive Switching Energy vs. Drain Current ( $V_{DD}=600\text{V}$ )\*

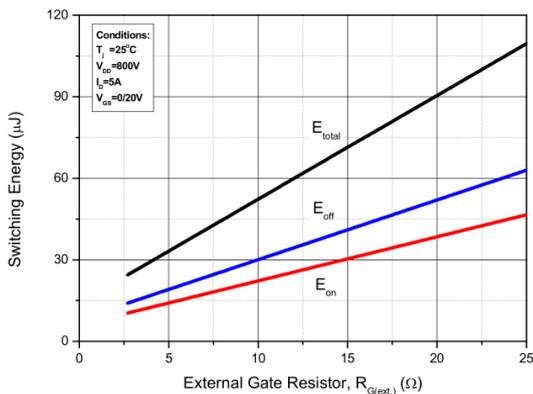
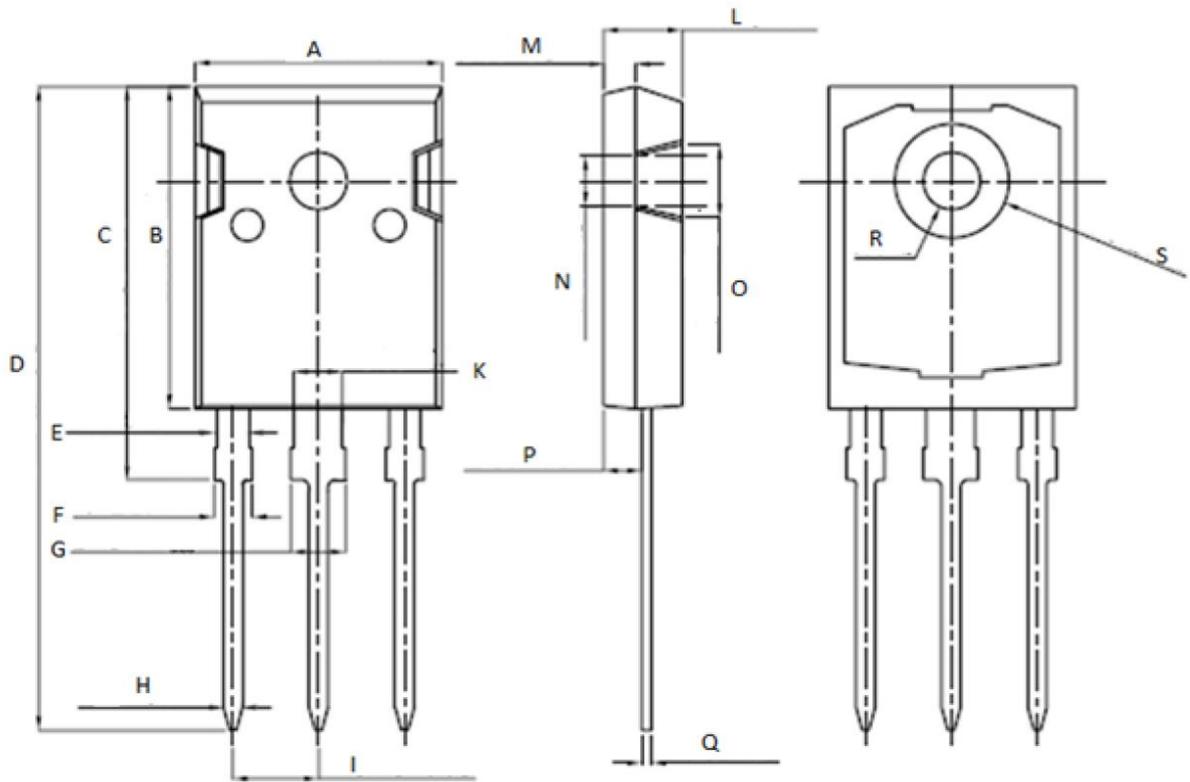


Fig. 21 Clamped Inductive Switching Energy vs. External Gate Resistor ( $R_{G(ext.)}$ )\*

\*Base on the results of calculation, note that the energy loss caused by the reverse recovery of FWD is not included in  $E_{on}$ .

**TO-247**


Unit: mm		
Symbol	Min.	Max.
A	15.95	16.25
B	20.85	21.25
C	20.95	21.35
D	40.5	40.9
E	1.9	2.1
F	2.1	2.25
G	3.1	3.25
H	1.1	1.3
I	5.40	5.50

Unit: mm		
Symbol	Min.	Max.
K	2.90	3.10
L	4.90	5.30
M	1.90	2.10
N	4.50	4.70
O	5.40	5.60
P	2.29	2.49
Q	0.51	0.71
R	φ 3.5	φ 3.7
S	φ 7.1	φ 7.3

\*The information provided herein is subject to change without notice.

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